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**PAPER**

Single-layer MoSeN – a synthetic Janus two-dimensional transition-metal compound grown by plasma-assisted molecular beam epitaxy

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Abstract

Two-dimensional (2D) nanomaterials hold immense application potentials such as in high-performance nano-electronics, and asymmetric 2D structures with inherent electric dipoles will extend the application promises. Yet synthesizing asymmetric 2D structures remains challenging. Herein, we report the first synthesis of single-layer (SL) hexagonal (*H*-) phase polar Janus MoSeN via nitrogen-plasma-assisted molecular beam epitaxy. This is a significant achievement given the incommensurate valence between Mo, Se, and N, and the inherent strain from the Janus architecture. Using an array of compositional and structural characterization methods, we establish the atomic configurations of the synthesized MoSeN SL, confirming that they are 2D Janus transition-metal chalcogen-nitrides rather than alloys. By employing density functional theory calculations and transport measurements, we explore the structural feasibility and offer insights into its electronic properties, demonstrating its metallic behavior with ohmic contact characteristics. Piezoresponse force microscopy measurements reveal vertical piezoelectricity and ferroelectric potentials from the Janus MoSeN SL. Therefore, it exhibits great potential for applications in, e.g. piezoelectric and ferroelectric devices, sensing technologies, and optoelectronic devices. This work not only addresses existing challenges in 2D nanomaterial research but also opens new avenues for the development of advanced functional materials.

1. Introduction

Single-layer (SL) Janus transition metal chalcogenides (TMCs) are atomically thin films of type *MXY*, where 'M' stands for a transition metal such as Mo while 'X' and 'Y' represent two different chalcogen elements (S, Se and Te) straddling the metal plane. Janus TMCs

hold many distinct properties different from the widely studied conventional transition-metal dichalcogenide (TMD) monolayers, such as MoS₂. For one, the Janus TMCs exhibit broken mirror symmetry along the vertical axis, leading to, for example, out-of-plane piezoelectricity [1], room-temperature ferromagnetism [2, 3], enhanced Rashba effect [4–6],

pronounced high order harmonic generation [7, 8], topological superconductivity [9], and skyrmions [3, 10]. As a result, there is a growing interest in synthesizing two-dimensional (2D) Janus TMCs soon after the first report of a synthetic Janus MoSeS monolayer by Lu *et al* [11]. Currently, two strategies have been adopted to approach 2D Janus TMCs [11–22]. In the first ‘one-step’ strategy, one plane of chalcogen atoms in the TMD SL (e.g. MoSe₂ or WSe₂) are directly replaced by another through sulfurization, achieving MoSeS or WSeS [16, 17, 19–21]. The other, ‘two-step’, approach consists of hydrogen (H) plasma or electron beam treatment of the TMDs followed by a chosen chalcogen element implantation [7, 11–15, 18, 23]. In the latter process, it is believed that the top layer chalcogen atoms in the TMD SL are stripped off by the remote H-plasma or by high-energy electron beam and then either replaced with H-atoms or remain vacant before finally substituted/-filled up by another chalcogen element upon heating under the chosen chemical environment, giving rise ultimately to the Janus MXY. The precise nature of the intermediate states in these processes, however, has not been well studied. Yet they can be critically important in the synthesis of Janus TMCs and hold special places for controlling their atomic configurations and/or stoichiometry. Indeed, the intermediate state of MoSH during the Janus TMC synthesis using H-plasma has been reportedly identified [14]. It was further predicted to own a metallic band structure [11, 14, 24, 25] and superconduct with a relatively high critical temperature ($T_c > 25$ K) [24, 25]. On the other hand, these properties remain to be fully characterized experimentally [14]. Besides, achieving a stable intermediate state during plasma-assisted synthesis of the Janus TMC would lead to an intriguing 2D Janus system that extends the currently studied Janus TMCs. Such non-TMC 2D Janus materials would bring in new properties beyond what the Janus TMC can offer. Firstly, the greater disparity in electronegativity between chalcogen elements and non-chalcogen elements makes non-TMC Janus film much highly polarized along the out-of-plane direction, which could lead to much enhanced piezoelectric effect. Secondly, unlike Janus TMCs where the two chalcogen atoms, though different (e.g. S versus Se), are isoelectronic, in a non-TMC Janus 2D film, there is a valance mismatch between the chalcogen atom layer and the non-chalcogen layer. Together with the inherent strain, it effectively results in heavy doping and alters the electronic band structure dramatically. It also brings a change of phonon modes due to light element implantation. All of these can give rise to novel electronic properties. For example, it can transform a semiconducting TMD layer into a metal and induce superconducting phase transitions at relatively higher critical temperatures. In turn, they may hold additional application potentials than the currently studied Janus TMCs. Therefore, exploring

Janus MXY compounds, where ‘Y’ is an element other than a chalcogen, is highly compelling from both scientific and practical perspectives.

In this work, we report the first synthesis of 2D Janus MoSeN in the hexagonal phase and its reversal to 1H-MoSe₂ in a molecular-beam epitaxy (MBE) setup equipped with a nitrogen (N) plasma unit. By employing low- and reflection high-energy electron diffraction (LEED/RHEED), annular dark field scanning transmission electron microscopy (ADF-STEM), x-ray/ultraviolet photoelectron spectroscopy (XPS/UPS), and Auger electron spectroscopy (AES), we establish the compositional and structural nature of the synthetic Janus MoSeN. The dynamic processes starting from the pristine MoSe₂ to the Janus MoSeN by N plasma treatment and subsequently its reversal back to MoSe₂ by selenization are followed in real-time by *in situ* RHEED. Piezoresponse force microscopy (PFM) measurements show vertical piezoelectricity from the Janus MoSeN SL, which is expected by the presence of out-of-plane dipole. The results further suggest ferroelectric potentials. The electronic bands and properties of the Janus MoSeN SL are investigated by density functional theory (DFT) calculations, showing that it is a metal as verified by transport measurements. The feasibility of synthesizing Janus MoSeN is also examined by DFT. The enhancement of phonon modes by the light N element and strong Mo–N bonds hint superconductivity of MoSeN at relatively high temperatures (~ 20 K).

The successful experimental realization of Janus MoSeN paves the way for exploring new physical phenomena and unlocks various application opportunities. Its piezoelectric and metallic characteristics make it highly suitable for applications such as in sensors for wearable flexible electronic devices and displays. By forming the metallic Janus MoSeN locally may improve ohmic contacts between the metal electrode and TMD devices. The anticipated superconductivity may also open an avenue for superconducting devices, such as superconducting quantum interference device and superconducting circuits for quantum computing. Therefore, MoSeN can be a very versatile material for future exploration.

2. Results and discussions

Pristine MoSe₂ was firstly grown on Au(111) by MBE at large scale and with low defect densities [26]. The MBE was equipped with a radio-frequency (RF) plasma unit, by which we treated the grown MoSe₂ *in situ* for Janus MoSeN formation. Selectively, we further reversed the synthetic MoSeN back to MoSe₂ by selenization. Figure 1(a) schematically depicts the synthesis procedure. The RHEED was adopted throughout to monitor the surface progression and figure 1(b) shows a set of representative RHEED patterns taken at different stages of the sample treatment process. The very top pattern (labeled ‘I’) is from the

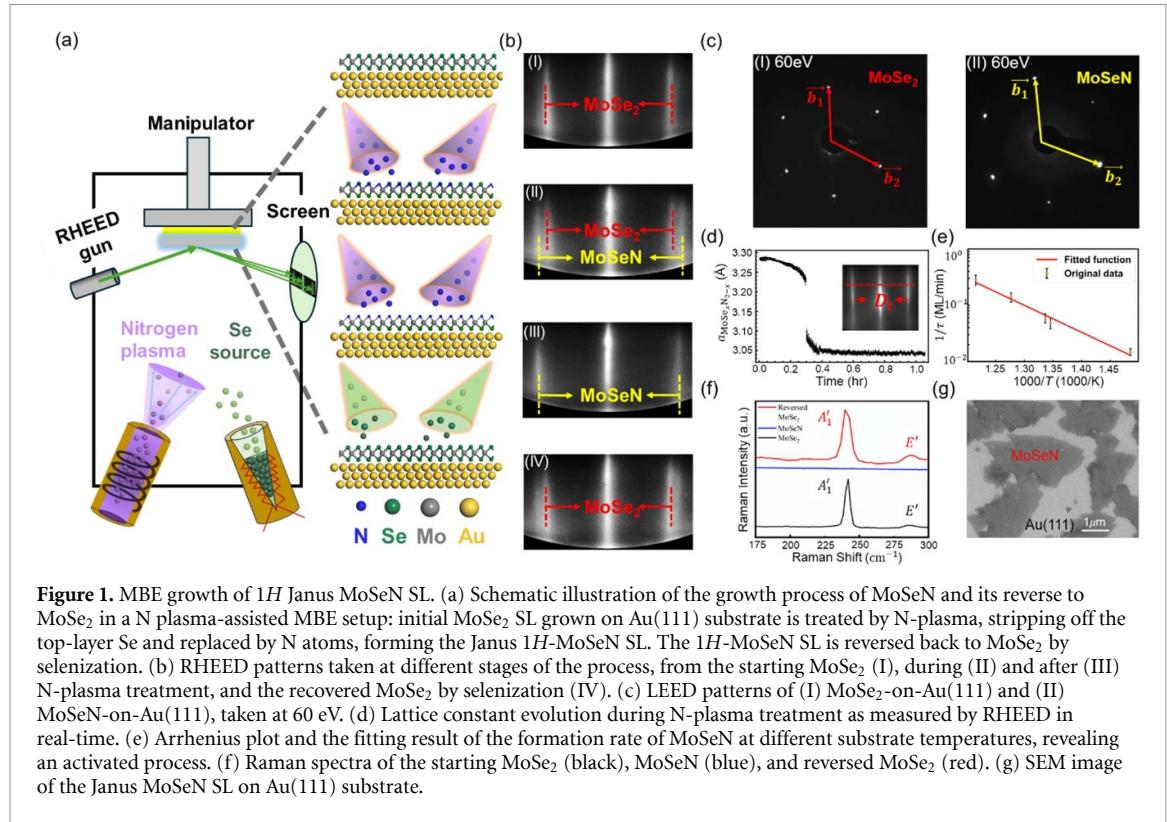


Figure 1. MBE growth of 1H Janus MoSeN SL. (a) Schematic illustration of the growth process of MoSeN and its reverse to MoSe₂ in a N plasma-assisted MBE setup: initial MoSe₂ SL grown on Au(111) substrate is treated by N-plasma, stripping off the top-layer Se and replaced by N atoms, forming the Janus 1H-MoSeN SL. The 1H-MoSeN SL is reversed back to MoSe₂ by selenization. (b) RHEED patterns taken at different stages of the process, from the starting MoSe₂ (I), during (II) and after (III) N-plasma treatment, and the recovered MoSe₂ by selenization (IV). (c) LEED patterns of (I) MoSe₂-on-Au(111) and (II) MoSeN-on-Au(111), taken at 60 eV. (d) Lattice constant evolution during N-plasma treatment as measured by RHEED in real-time. (e) Arrhenius plot and the fitting result of the formation rate of MoSeN at different substrate temperatures, revealing an activated process. (f) Raman spectra of the starting MoSe₂ (black), MoSeN (blue), and reversed MoSe₂ (red). (g) SEM image of the Janus MoSeN SL on Au(111) substrate.

starting MoSe₂ grown on Au(111), where the spacing D between the (01) and (01̄) streaks as marked by the dashed red lines reflects the lattice constant of MoSe₂ (i.e. $a_{\text{MoSe}_2} \approx 3.33 \text{ \AA}$). When exposed to N-plasma, the surface roughens as reflected by the broadening of the RHEED streaks. A new set of streaks also emerges on the outskirt (see 'II' in figure 1(b)), indicating a film with a smaller lattice constant than that of MoSe₂ starts to form. We tentatively assign the latter to be of MoSe_xN_{2-x}. Indeed, the shorter Mo–N bond length than Mo–Se expectedly leads to a compressed lattice. As N-plasma treatment progresses, the diffraction streaks of MoSe₂ subsides while the new set of streaks brightens up and also widens until it stabilizes at a value $\sim 9\%$ more than that of pristine MoSe₂ (see 'III' in figure 1(b) as well as figure 1(d)). We believe latter to correspond to the situation where a full Se layer in MoSe₂ has been substituted by N, i.e. the realization of the Janus MoSeN SL. This conclusion will be further confirmed through STEM and other characterization techniques. As $D \propto 1/a$, we may derive the lattice constant, a_{MoSeN} , of MoSeN to be approximately 3.04 Å according to the relation: $a_{\text{MoSeN}}/a_{\text{MoSe}_2} = D_{\text{MoSe}_2}/D_{\text{MoSeN}}$, where D_{MoSe_2} and D_{MoSeN} refer to the measured inter-streak spacings of MoSe₂ and MoSeN, respectively. For comparison and completeness, after the lattice stabilized at 3.04 Å, we selectively performed the reversal experiments by switching off N-plasma and turning on Se flux again. A gradual change of the RHEED in reverse order, i.e. from that of MoSeN back to MoSe₂ was clearly noted ('IV' in figure 1(b)), implying the recovery

of MoSe₂ film. The RHEED results are corroborated by the LEED measurements as exemplified in figure 1(c), which shows two patterns taken from the starting MoSe₂ (I) and the synthesized MoSeN (II) films, respectively. As seen, besides the lattice constant change consistent with the RHEED, the LEED also reveals good crystallinity of the samples. In particular, rotation and twin domains are suppressed as indicated by the 3-fold diffraction spots.

Next, we examined the temperature dependence of MoSeN formation. While similar behavior was observed over a wide range of temperatures, the rate of MoSeN formation clearly varies. We specifically recorded the time τ taken for the MoSeN pattern to stabilize under different substrate temperatures T and plotted in figure 1(e) in an Arrhenius plot, revealing an activated process according to $\frac{1}{\tau} \propto e^{-E/k_B T}$, where k_B is the Boltzmann constant and E is the energy barrier of the process. This behavior suggests that knocking out the Se atoms from MoSe₂ and substituting them by N was not caused solely by the kinetic energy of N atoms from plasma, but also by temperature. By a least-square fitting of the data, we derive a value of the activation energy, $E \sim 0.95 \text{ eV}$.

We have also adopted Raman spectroscopy to identify the bonding characteristics of the synthesized MoSeN but to no avail because, as will be shown later, it is metallic. On the other hand, for semiconducting 1H-MoSe₂ obtained by reversal from MoSeN, we did observe both the out-of-plane A'_1 mode at 240 cm^{-1} and the in-plane E' mode at 285 cm^{-1} , consistent with that from the starting pristine MoSe₂ film as

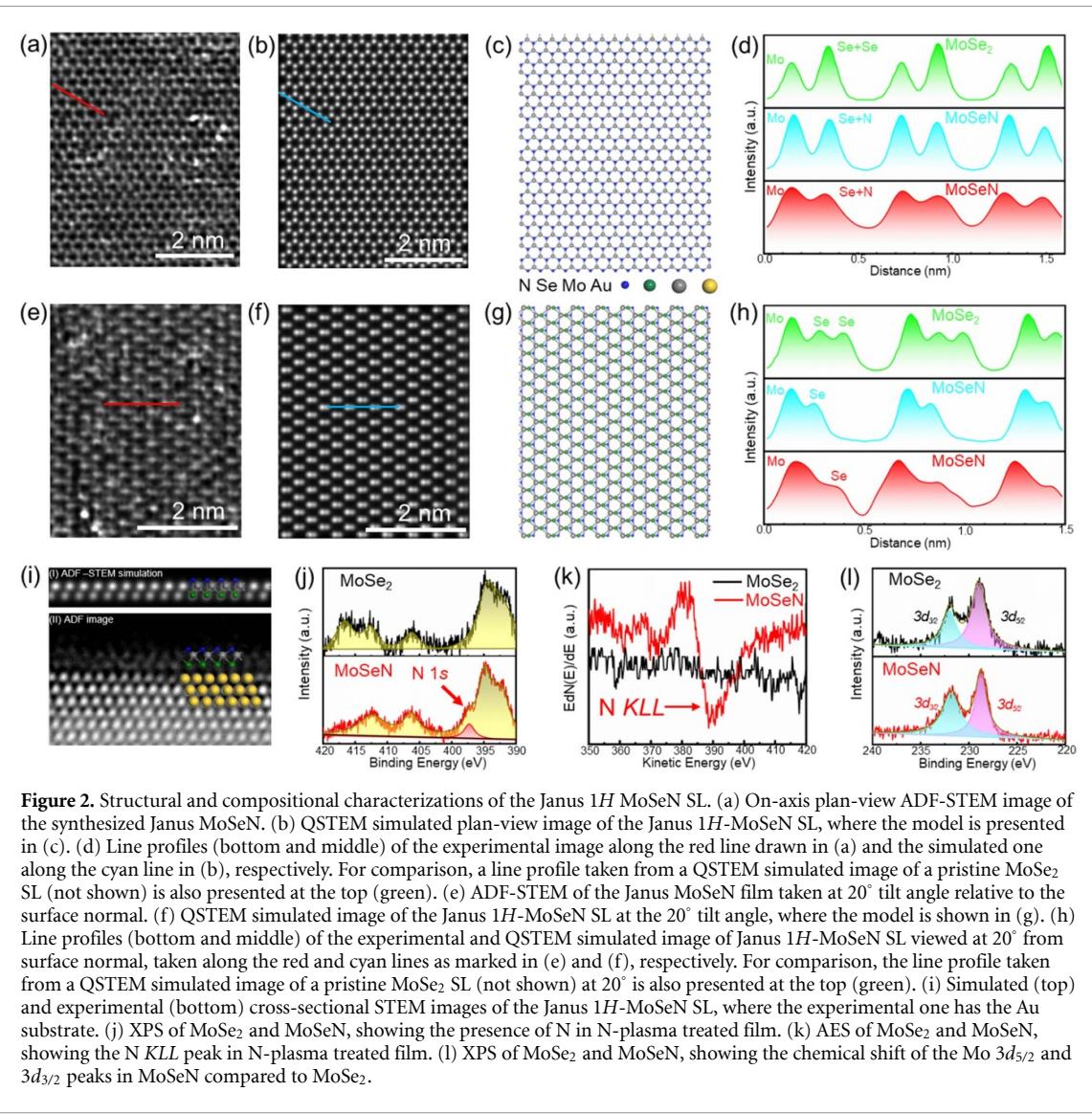


Figure 2. Structural and compositional characterizations of the Janus 1H MoSeN SL. (a) On-axis plan-view ADF-STEM image of the synthesized Janus MoSeN. (b) QSTEM simulated plan-view image of the Janus 1H-MoSeN SL, where the model is presented in (c). (d) Line profiles (bottom and middle) of the experimental image along the red line drawn in (a) and the simulated one along the cyan line in (b), respectively. For comparison, a line profile taken from a QSTEM simulated image of a pristine MoSe₂ SL (not shown) is also presented at the top (green). (e) ADF-STEM of the Janus MoSeN film taken at 20° tilt angle relative to the surface normal. (f) QSTEM simulated image of the Janus 1H-MoSeN SL at the 20° tilt angle, where the model is shown in (g). (h) Line profiles (bottom and middle) of the experimental and QSTEM simulated image of Janus 1H-MoSeN SL viewed at 20° from surface normal, taken along the red and cyan lines as marked in (e) and (f), respectively. For comparison, the line profile taken from a QSTEM simulated image of a pristine MoSe₂ SL (not shown) at 20° is also presented at the top (green). (i) Simulated (top) and experimental (bottom) cross-sectional STEM images of the Janus 1H-MoSeN SL, where the experimental one has the Au substrate. (j) XPS of MoSe₂ and MoSeN, showing the presence of N in N-plasma treated film. (k) AES of MoSe₂ and MoSeN, showing the N KLL peak in N-plasma treated film. (l) XPS of MoSe₂ and MoSeN, showing the chemical shift of the Mo 3d_{5/2} and 3d_{3/2} peaks in MoSeN compared to MoSe₂.

shown in figure 1(f). The morphology of the synthesized MoSeN was examined by scanning electron microscopy (SEM). Figure 1(g) presents an example where the coverage was purposely made less than a full layer to intentionally reveal the contrast difference between MoSeN and the substrate. Essentially, the sample retained more or less same triangular domains, although damages in microscopic scales were inevitable.

To characterize the atomic configurations of N plasma treated samples, we resorted to STEM, both in plan- and cross-sectional views. For the former, we further experimented at two incidence angles: on-axis and at 20° tilt from the surface normal. The results are presented in figures 2(a)–(e), respectively. From figure 2(a), one firstly notes that the N-plasma treated film takes the same hexagonal ring structure as pristine MoSe₂, though the contrast within a honeycomb ring appears more uniform than the 3-fold rings of a pristine MoSe₂ SL (see supplementary information figure (S1)). Indeed, quantitative STEM simulations (QSTEM) of the 1H-phase Janus MoSeN

SL (figure 2(b)) reveals similarly uniform rings, while line profile analysis depicted in figure 2(d) from the experimental data (shown in red, taken along the red line in figure 2(a)) also matches well with the simulated profile from a 1H Janus MoSeN (shown in cyan, taken along the cyan line in figure 2(b)), but less so with the simulated data from a 1H MoSe₂ SL (green). More supporting results about the Janus MoSeN comes from ADF-STEM imaged at the 20° tilt angle (figure 2(e)). As seen from figure 2(h), the intensity profile (red) correlates well with that (cyan) of the simulated one of a Janus MoSeN and is in odd with that of a MoSe₂ SL (green). Therefore, we assert that a Janus MoSeN film is obtained by N-plasma treatment of MoSe₂ SL on Au(111) substrate.

A more convincing result about the Janus MoSeN is obtained by cross-sectional ADF-STEM. Figure 2(i) presents an experimental image (bottom) together with the QSTEM simulation (top) of the Janus 1H-MoSeN on Au (111). The light element of N manifests no contrast in ADF-STEM, so it may appear no different from a Se vacancy. But in any case, the

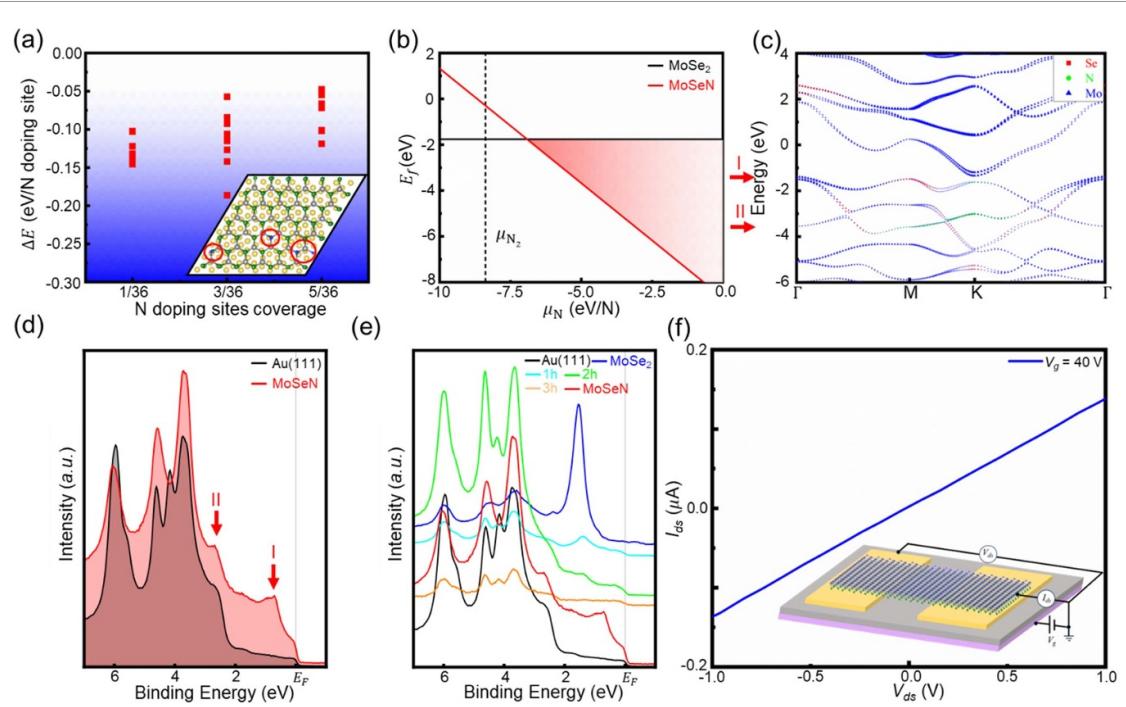


Figure 3. Electronic structure of Janus 1H-MoSeN. (a) DFT calculated total energy differences between top- and bottom-layer Se being randomly substituted by N at coverages of 1/36, 3/36 and 5/36 monolayers, respectively. Inset: supercell of 6 × 6 N doped MoSe₂ SL on 7 × 7 Au(111) of 3-layer thickness. (b) Formation energies of the Janus MoSeN (solid red line) and pristine MoSe₂ SL (solid black line) plotted as a function of nitrogen chemical potential, where $E_f(\text{MoSe}_2) = E_{\text{MoSe}_2} - E_{\text{Mo}} - 2E_{\text{Se}}$ for MoSe₂ and $E_f(\text{MoSeN}) = E_{\text{MoSeN}} - E_{\text{Mo}} - E_{\text{Se}} - \mu(\text{N})$ for the Janus MoSeN. The chemical potential of N₂ is marked by the vertical dashed line for reference. (c) Element-projected band structure of the Janus 1H-MoSeN SL. The two red arrows drawn on left mark the two major bands below Fermi level that may have manifested by the two UPS peaks shown in (d), in which spectra of Au(111) (black) and 1H-MoSeN SL (red) are shown for comparison. (e) Evolution of UPS spectra obtained at different N plasma dosages, starting from the pristine MoSe₂ (blue), at 1 h (cyan), 2 h (green), and 3 h (orange) plasma-treatment at a N₂ flow rate of 1.6 sccm and power of 75 W, finally the Janus MoSeN (red) after 4h treatment. The UPS spectrum of a clean Au(111) is displayed in black. (f) Current-voltage characteristic (I_{ds} versus V_{ds}) of the Janus MoSeN measured at gate voltage $V_g = 40$ V, showing a linear $I_{\text{ds}} - V_{\text{ds}}$ curve in a wide range of $|V_{\text{ds}}| \leq 2$ V consistent with the metallic behavior (inset: device schematics). See supplementary information for more details.

Se-layer at the bottom (i.e. adjacent to Au) is seen intact. Therefore nitrogen, if present, must almost all locate on the top plane, consistent with the assignment of a Janus MoSeN SL than an alloy. If it were an alloy, N atoms would have replaced Se randomly in both the top and bottom planes. To show that N does exist, we adopted XPS and AES measurements as presented in figures 2(j) and (k), respectively. In the XPS spectra, the N 1 s peak is discerned in the N-plasma treated sample, whereas no sign of N is identified in the sample before the treatment. In AES, again the treated sample revealed nitrogen KLL transition, while the untreated sample showed no signature of such. In figure 2(l), we show XPS of Mo 3d_{5/2} and 3d_{3/2} orbitals for both MoSe₂ and MoSeN SLs. One notes the chemical shifts of the Mo 3d peaks: from 228.96 eV to 228.74 eV for 3d_{5/2} and from 231.99 eV to 231.82 eV for 3d_{3/2}. These shifts reflect the Mo-N bonding that has caused a change of charge distribution around Mo, affirming again the presence of N that are bonded with Mo in sample.

The Janus MoSeN SL is non-existent in nature. Its formation from MoSe₂ upon N-plasma treatment as well as its stability deserve an attention. To this end, we adopted DFT calculations to show firstly

that the Janus 1H-MoSeN SL adopts the trigonal space group P3m1 (No.156) with a lattice constant of 3.1 Å, which is consistent with our RHEED results of 3.04 Å. Subsequently, we have explored the formation processes of MoSeN from Au-supported MoSe₂ SL. Specifically, a 6 × 6 supercell of MoSe₂ on 7 × 7 three-layer-thick Au substrate is chosen in the calculation, where the top two layers of Au atoms are allowed to relax while the remaining layer is fixed at the bulk lattice sites. Se in both the top (adjacent to the vacuum) and bottom (adjacent to gold) layers were substituted randomly by one, three, and five N atoms (see figure 3(a)). The energy difference, $\Delta E = E_{\text{top}} - E_{\text{bottom}}$, between the top- and bottom-layer Se substitution by N were derived. It is found that the ΔE 's are consistently less than zero for the three N doping sites coverage (i.e. 1/36, 3/36, and 5/36 monolayers), implying that N substituting Se in the top layer is preferable during the initial N-plasma treatment processes. It aligns with the experimental finding that the Janus MoSeN has the N-layer on top. More importantly, as shown in figure 3(b), the formation energy of the Janus MoSeN can be downshifted to below that of pristine MoSe₂ by increasing the chemical potential of N over a critical value. In other

words, at sufficiently high N fluxes, the Janus MoSeN can favorably form. The element-resolved band structure of the Janus 1H-MoSeN as calculated by DFT is presented in figure 3(c), revealing a metallic nature of the material. Our UPS measurements as depicted in figure 3(d) reveals two distinct peaks at binding energies of ~ 0.8 eV and 2.7 eV below the Fermi level, which may correlate to the two Γ -point bands as marked in figure 3(c). To follow the formation process of MoSeN, we progressively treated MoSe₂ SL by mild N plasma at different dosages and recorded the UPS spectra: 0, 1-, 2-, 3-, and 4 hours N-plasma treatment at N₂ flow rate of 1.6 sccm and power of 75 W. The formation of MoSeN was seen to be associated with a shift of the binding energy and eventual disappearance of the primary MoSe₂ peak below Fermi level E_F but the emergence of new peaks of Janus MoSeN. This aligns with the RHEED results displaying subsiding pattern of MoSe₂ and appearance of the new set of diffraction patterns during N-plasma treatment. Transport measurements indicate a linear response over a wide range of drain voltage up to 2 V and ohmic contact behavior of MoSeN film, consistent with the expected metallic characteristics (see figure 3(f) and supplementary information figure S2(b)). Finally, we further obtained the phonon spectra of MoSeN by DFT calculations, which are shown in supplementary information figure S3(a). It is noted that it is devoid of unstable modes in Brillouin zone, substantiating the dynamic stability of the Janus 1H-MoSeN SL (see supplementary information figure S3(a)). Besides, the enhanced phonon mode (see supplementary information figure S3(b)) expected from the light N element and strong Mo-N bonds and the added carrier doping per an incommensurate valence between N and Se hint for superconductivity of MoSeN. Furthermore, our study demonstrates that Janus transition-metal chalcogen nitrides based on Nb, Mo, and W are mechanically stable and exhibit superconducting critical temperatures approaching approximately 20 K. For more details, please refer to the supplementary information. Experimental verification of the latter is however hinted by substrate effect and sample quality.

Lastly, mirror symmetry breaking transforms the D_{3h} group MoSe₂ SL to the C_{3v} symmetry group of Janus MoSeN SL, which brings in vertical piezoelectricity as predicted in many DFT calculations [2, 3, 27]. In figures 4(a) and (b), we present respectively topographic and piezoelectric amplitude images in the same region of a Janus MoSeN sample on Au(111) measured by resonance-enhanced PFM. In both images, a Janus MoSeN island is highlighted by a dashed red triangle that manifests by different contrasts in the two different measurement modes. Figure 4(c) displays the vertical PFM responses in amplitude and phase; notably, the amplitude signal exhibits clear butterfly-shaped electric hysteresis loops. The phase difference between the two

polarization states is 180° and the minima in the amplitude loop coincide with the switching voltages in the phase signal, indicating strong piezoelectricity and the possibility of room-temperature ferroelectricity. Our DFT calculations reveal a significant charge imbalance on the two sides of the Mo plane (see figure 4(d)), leading to robust net dipoles along the vertical direction. This elucidates the origin of the experimentally observed piezoelectricity.

We have successfully synthesized single-layer (*H* phase) Janus MoSeN on Au(111) substrates using nitrogen-plasma-assisted MBE. Comprehensive compositional and structural characterizations were conducted using a combination of analytical techniques, including electron diffraction, photoelectron and AES, and ADF-STEM. Nitrogen atoms supplied by the RF-plasma unit substitute selenium atoms in the top plane of MoSe₂, leading to the formation of a MoSeN film with broken mirror symmetry. Remarkably, this MoSeN layer can be reversed back to MoSe₂ through a simple selenization step. Adopting the RHEED, we have, for the first time, monitored the entire synthesis and reversal processes of MoSeN in real time. Moreover, the temperature dependence of the reaction rate suggests a thermally activated process for plasma assisted MoSeN formation. DFT calculations elucidate the substitution mechanism of nitrogen atoms during the formation and stabilization of MoSeN. Furthermore, DFT results indicate an enhancement of phonon modes, suggesting potential superconductivity. Transport measurements reveal that this synthetic 2D Janus material is metallic, exhibiting ohmic behavior. The broken mirror symmetry in Janus MoSeN leads to out-of-plane piezoelectricity, which has been experimentally verified through PFM. The observations also indicate possible ferroelectricity, offering promise for various device applications. The method we adopted for the synthesis of the Janus MoSeN may be of general applicability, providing a viable route for finely controllable synthesis of other 2D Janus materials with great application potentials in electronics, catalysis, and energy technologies.

3. Methods

3.1. Sample preparation

The growths of MoSe₂ thin films were carried out in a customized MBE chamber having a background pressure of $\sim 10^{-10}$ Torr. The flux of molybdenum was generated from an e-beam evaporator operated at the power of ~ 45 W, while that of selenium was provided from a conventional Knudsen cell held at ~ 125 °C. The Se and Mo fluxes were estimated to be $\sim 3 \times 10^{12}$ and $\sim 1.5 \times 10^{11}$ atom/cm²·s, respectively. Single-crystalline bulk Au(111) substrate was cleaned by successive Argon ion bombardment (1.5 kV, 2×10^{-5} mbar) followed by annealing at ~ 550 °C

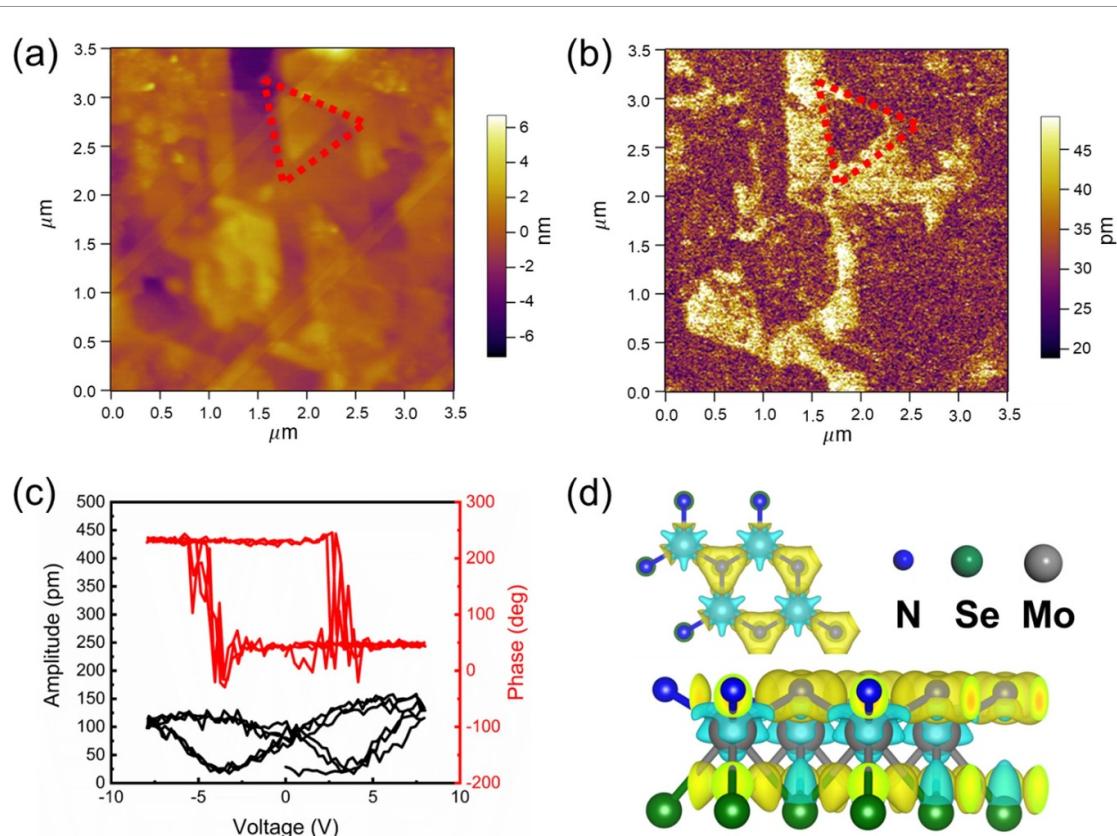


Figure 4. Out-of-plane piezoelectric responses of Janus 1H-MoSeN samples. Topographic (a) and piezoelectric amplitude (b) images of the Janus 1H-MoSeN SL grown on Au (111), measured by resonance-enhanced PFM. (c) PFM phase (red) and amplitude (black) hysteretic loops taken from the same region of a MoSeN SL. (d) Top- and side-views of charge density difference distribution in Janus 1H-MoSeN. Blue, green and gray balls denote N, Se and Mo atoms, respectively. Cyan and yellow colors denote positive and negative charge, respectively.

for at least ten cycles. Nitrogen plasma was generated from RF (13.56 MHz) plasma unit from Oxford Applied Research (HD25). The operation power was 75 W. N₂ flow rate was 1.6 sccm. The substrate temperatures was ~ 400 °C except for the temperature dependent experiments explicitly stated. *In situ* RHEED was conducted using a system from Staib Instruments, operating at an energy of 10 keV.

3.2. Sample exfoliation

For transport measurement, exfoliation of the grown MoSeN was done by the following procedure: Firstly, polymethylmethacrylate (PMMA) (A4, 950 K) was spin-coated on the Au/mica supported sample at 3000 rpm for 60 s and baked at 120 °C for 90 s. Then hydrofluoric acid was used to etch away mica, which was followed by Au film etching in the gold etchant (potassium iodide).

3.3. STEM characterization and QSTEM simulation

Samples grown on Au bulk crystals or on Au/mica were characterized by ADF-STEM, where the specimen were made by chemical etching and transferred onto a molybdenum-based TEM grid. Atomic-resolution ADF-STEM were performed in a probe-corrected TEM (FEI Titan Chemi STEM G2) operated at 200 kV. The convergence semi-angle was set

at 21.4 mrad and the range of acceptance angle of the ADF detector was 53–200 mrad. Cross-sectional STEM specimen was prepared via the focused ion beam (FIB) technique (FEI Helios G4), during which cares like coating of amorphous carbon and platinum as protected layers and low-voltage polishing at 5 kV (48 pA current) were taken to minimize sample damage. As-milled FIB samples were further treated with argon ions (Gatan 691 precision ion polishing system) at 2 kV and 24 pA to remove residual surface contaminations and damage layers. The raw ADF-STEM images were filtered with an improved Wiener filter to improve the signal-to-noise ratio for better display. All the simulated ADF-STEM images were generated by using software QSTEM (ref. Koch, C. T. Determination of Core Structure Periodicity and Point Defect Density Along Dislocations. PhD Thesis, Arizona State University, 2002.), with identical parameter settings to those used in the experimental conditions. Additionally, thermal diffuse scattering was accounted for in all QSTEM simulations.

3.4. PFM measurements

The piezoelectric responses and hysteresis loops measurements were conducted using Scanning Probe Microscope (Asylum MFP-3D Infinity) in dual ac resonance tracking piezo force microscopy mode. A

Pt/Ir coated conductive probe with a force constant of 2.8 N m^{-1} was used in all PFM characterizations under an AC bias V_{ac} of 2–4 V. The Q quality factor was acquired during the contact resonance frequency tuning of the PFM probe and the sample surface.

3.5. DFT calculations

The calculations are performed within the optimized norm conserving Vanderbilt pseudopotentials and general gradient approximation (GGA-PBE) for the exchange-correlation energy functional, as implemented in the QUANTUM ESPRESSO package, with cutoffs of 80 Ry for the wave functions and 320 Ry for the charge density. The Brillouin zone integrations are done with the optimized tetrahedron method on a 40×40 Monkhorst-Pack grid k -mesh. The internal atomic positions are fully relaxed with a threshold of 10 meV \AA^{-1} for the forces. A vacuum of thickness $\sim 15 \text{ \AA}$ perpendicular to the monolayer with the inclusion of 2D Coulomb truncation is used to avoid the periodic interactions along the c -axis. The phonon dispersion is calculated within density functional perturbation theory on a 50×50 q -mesh using the Phonon module in the QUANTUM ESPRESSO package

3.6. XPS/UPS

Both UPS and XPS measurements were carried out in a separate vacuum chamber connected to the MBE via vacuum interlock. For XPS, Al $K\alpha$ (1486.6 eV) was adopted, a twin-anode (Mg/Al) x-ray source from VG (Model XR3 $\times 10^2$). For UPS, He I (21.2 eV) was used. The energy analyzer is PHOIBOS100MCD-5 from SPECS.

3.7. AES/LEED

AES measurements were conducted using a digital LEED-AES system (model LOA10-D) at the following settings: a filament current of 1.6 A, Wehnelt voltage of 20.2 V, beam voltage of 1500 V, focus voltage of 1140 V, emission current of 42 μA , and beam current of 38 μA . LEED experiments were performed using a Scienta Omicron SpectalLEED control unit, with a filament current of 1.05 A, screen voltage of 6 kV, and beam voltages ranging from 40 to 200 V.

Data availability statement

The data cannot be made publicly available upon publication because no suitable repository exists for hosting data in this field of study. The data that support the findings of this study are available upon reasonable request from the authors.

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